

# Search Notes



Application/Control No.

10/652,331

Examiner

Nhan T. Le

Applicant(s)/Patent under Reexamination

YEO ET AL.

Art Unit

2685

## SEARCHED

Class	Subclass	Date	Examiner
455	131	01/13/06	N Le
	313		
	324		
	323		
371	283		
	386		
375	340		
	346		
	324		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Eastsearch	01/13/06	N, Le